

<i>Notice of References Cited</i>	Application/Control No. 10/541,896		Applicant(s)/Patent Under Reexamination YELLAND ET AL.	
	Examiner Brian Szmal		Art Unit 3736	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0002636 A1	01-2004	Teicher et al.	600/300
*	B	US-5,801,810	09-1998	Roenker, Daniel L.	351/246
*	C	US-6,317,128 B1	11-2001	Harrison et al.	345/629
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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